Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/735,154	KO, DAVID (TSO-CHIN)
Examiner	Art Unit
Edwin A. León	2833

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Class	Subclass	Date	Examiner	
439	607-610	4/8/2005	EAL	
439	660	4/8/2005	EAL	
439	492-495	4/8/2005	EAL	
439	79	4/8/2005	EAL	
439	571-573	4/8/2005	EAL	
439	629	4/8/2005	EAL	
439	108	4/8/2005	EAL	
439	901	4/8/2005	EAL	
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